

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination TREZZA ET AL.	
		Examiner	Art Unit	Page 1 of 1
		Phillip Nguyen	2828	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,914,976 A	06-1999	Jayaraman et al.	372/50,21
*	B	US-2003/0002555 A1	01-2003	Tran et al.	372/50
*	C	US-5,136,152 A	08-1992	Lee, Wai-Hon	257/699
*	D	US-6,483,862 B1	11-2002	Aronson et al.	372/50,21
*	E	US-5,491,712 A	02-1996	Lin et al.	372/50,21
*	F	US-6,084,848 A	07-2000	Goto, Kenya	369/121
*	G	US-5,978,401	11-1999	Morgan, Robert A.	372/50,21
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.